TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74HC4066AP,TC74HC4066AF,TC74HC4066AFN,TC74HC4066AFT

Quad Bilateral Switch

The TC74HC4066A is a high speed CMOS QUAD BILATERAL SWITCH fabricated with silicon gate C^2MOS technology.

It consists of four independent high speed switches capable of controlling either digital or analog signals while maintaining the CMOS low power dissipation.

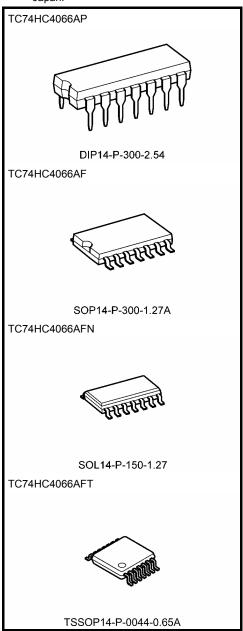
Control input (C) is provided to control the switch. The switch turns ON while the C input is high, and the switch turns OFF while low.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

Features

- High speed: $t_{pd} = 7 \text{ ns (typ.)}$ at $V_{CC} = 5 \text{ V}$
- Low power dissipation: $I_{CC} = 1 \mu A$ (max) at $T_a = 25$ °C
- High noise immunity: V_{NIH} = V_{NIL} = 28% V_{CC} (min)
- Low on resistance: R_{ON} = 50 Ω (typ.) at V_{CC} = 9 V
- High degree of linearity: THD = 0.05% (typ.) at $V_{CC} = 5 \text{ V}$
- Pin and function compatible with 4066B

Note: xxxFN (JEDEC SOP) is not available in Japan.

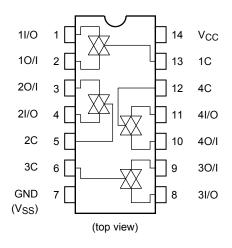


Weight

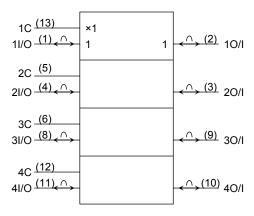
DIP14-P-300-2.54 : 0.96 g (typ.) SOP14-P-300-1.27A : 0.18 g (typ.) SOL14-P-150-1.27 : 0.12 g (typ.) TSSOP14-P-0044-0.65A : 0.06 g (typ.)



Pin Assignment



IEC Logic Symbol



Truth Table

Control	Switch Function
Н	On
L	Off



Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V_{CC}	−0.5 to 13	V
Control input voltage	V _{IN}	-0.5 to V _{CC} + 0.5	V
Switch I/O voltage	V _{I/O}	-0.5 to V _{CC} + 0.5	V
Control input diode current	I _{IK}	±20	mA
I/O diode current	lok	±20	mA
Switch through Current	lout	±25	mA
DC V _{CC} /ground current	I _{CC}	±50	mA
Power dissipation	PD	500 (DIP) (Note 2)/180 (SOP/TSSOP)	mW
Storage temperature	T _{stg}	−65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: 500 mW in the range of Ta = -40 to 65°C. From Ta = 65 to 85°C a derating factor of -10 mW/°C should be applied up to 300 mW.

Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage	V _{CC}	2 to 12	V
Control input voltage	V _{IN}	0 to V _{CC}	V
Switch I/O voltage	V _{I/O}	0 to V _{CC}	V
Operating temperature	T _{opr}	-40 to 85	°C
	t _{r,} t _f	0 to 1000 (V _{CC} = 2.0 V)	
Input rice and fall time		0 to 500 (V _{CC} = 4.5 V)	ns
Input rise and fall time		0 to 400 (V _{CC} = 6.0 V)	115
		0 to 250 (V _{CC} = 10.0 V)	

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused control inputs must be tied to either VCC or GND.



Electrical Characteristics

DC Characteristics

Characteristics Symbol		Test Condition		Ta = 25°C			Ta = −40 to 85°C		Unit	
				Min	Тур.	Max	Min	Max	Oille	
			2.0	1.50	_	_	1.50	_		
High-level control	V		4.5	3.15	_	_	3.15	_	٧	
input voltage	V_{IHC}	_	9.0	6.30	_	_	6.30	_		
				8.40	_	_	8.40	_		
			2.0	_	_	0.50	_	0.50		
Low-level control	V_{ILC}		4.5	_	_	1.35	_	1.35	V	
input voltage	VILC	_	9.0	_	_	2.70	_	2.70	V	
			12.0	_	_	3.60	_	3.60		
		V _{IN} = V _{IHC}	4.5	_	96	170	_	200		
		$V_{I/O} = V_{CC}$ to GND	9.0	_	55	85	_	100		
		I _{I/O} ≤ 1 mA	12.0	_	45	80	_	90		
On resistance	R _{ON}	V = V	2.0	_	160	_	_	_	Ω	
		$V_{IN} = V_{IHC}$ $V_{I/O} = V_{CC}$ or GND $I_{I/O} \le 1$ mA	4.5	_	70	100	_	130		
			9.0	_	50	75	_	95		
			12.0	_	45	70	_	90		
Difference of on		V _{IN} = V _{IHC}	4.5	_	10	_	_	_		
resistance between	ΔR_{ON}	$V_{I/O} = V_{CC}$ to GND	9.0	_	5	_	_	_	Ω	
switches		$I_{I/O} \le 1 \text{ mA}$ $12.0 - 5 -$		_	_	_				
Input/output leakage		V _{OS} = V _{CC} or GND								
current	I _{OFF}	V_{IS} = GND or V_{CC}	12.0	_	_	±100	_	±1000	nA	
(switch off)		V _{IN} = V _{ILC}								
Switch input leakage current	n input leakage	V _{OS} =V _{CC} or GND								
(switch on, output open)		V _{IN} = V _{IHC}	12.0	_	_	±100	_	±1000	nA	
		VIN - VIHC								
Control input current	I _{IN}	V _{IN} = V _{CC} or GND	12.0	_	_	±100	_	±1000	nA	
Quiescent supply current	Icc		6.0	_	_	1.0	_	10.0		
		V _{IN} = V _{CC} or GND	9.0	_	_	4.0	_	40.0	μΑ	
			12.0	_	_	8.0	_	80.0		



AC Characteristics ($C_L = 50 \text{ pF}$, input: $t_r = t_f = 6 \text{ ns}$)

Characteristics	Symbol	Symbol Test Condition .		Ta = 25°C			Ta = -40 to 85°C		Unit	
			VCC (V)	Min	Тур.	Max	Min	Max		
			2.0	_	10	50	_	65	pF	
Phase difference between input and	(0) -		4.5	_	4	10	_	13		
output	ФІ-О	_	9.0	_	3	8	_	10		
			12.0	_	3	7	_	9		
			2.0	_	18	100	_	125		
Output anabla tima	t_{pZL}	B. = 1 kO	4.5	_	8	20	_	25	pΕ	
Output enable time	t _{pZH}	$R_L = 1 k\Omega$	9.0	_	6	12	_	22	pF	
			12.0	_	6	12	_	18		
	t_{pLZ} t_{pHZ} $R_L = 1 \text{ k}\Omega$		2.0	-	20	115	_	145	pF	
Output disable time		R _L = 1 kΩ	4.5	_	10	23	_	29		
Output disable time			9.0	_	8	20	_	25		
		12.0	_	8	18	_	22			
		$R_L = 1 \text{ k}\Omega$ $C_L = 15 \text{ pF}$	2.0	_	30	_	_	_	MHz	
Maximum control			4.5	_	30	_	_	_		
input frequency			9.0	_	30	_	_	_		
		V_{OUT} = 1/2 V_{CC}	12.0	_	30	_	_	_		
Control input capacitance	C _{IN}	_		_	5	10	_	10	pF	
Switch terminal capacitance	C _{I/O}	_		_	6	_	_	_	pF	
Feed through capacitance	C _{IOS}	_		_	0.5	_	_	_	pF	
Power dissipation capacitance	C _{PD}		(Note)	_	15	_	_	_	pF	

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

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Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/4 (per channel)$



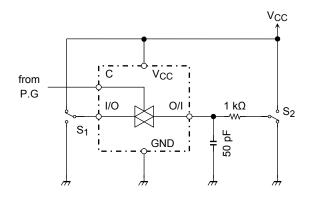
Analog Switch Characteristics (GND = 0 V, Ta = 25°C) (Note)

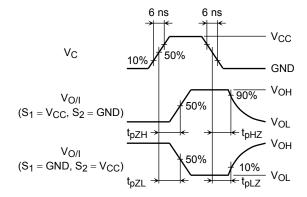
Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Sine wave distortion (T.H.D)		$f_{IN} = 1 \text{ kHz}, V_{IN} = 4 \text{ V}_{p-p}, @V_{CC} = 4.5 \text{ V}$ $R_L = 10 \text{ k}\Omega, V_{IN} = 8 \text{ V}_{p-p}, @V_{CC} = 9.0 \text{ V}$ $C_L = 50 \text{ pF}$	4.5 9.0	0.05 0.04	%
Frequency response (switch on)	f _{max}	Adjust f_{IN} voltage to obtain 0dBm at V_{OS} Increase f_{IN} frequency until dB meter reads -3dB R_{L} = 50 Ω , C_{L} = 10 pF f_{IN} = 1 MHz, sine wave	4.5 9.0	200 200	MHz
Feedthrough attenuation (switch off)		Vin is centered at $V_{CC}/2$ Adjust input for 0dBm $R_L = 600 \ \Omega, \ C_L = 50 \ pF$ $f_{IN} = 1 \ MHz$, sine wave	4.5 9.0	-60 -60	dB
Crosstalk (control input to signal output)		R_L = 600 Ω, C_L = 50 pF $f_{ N}$ = 1 MHz, square wave (t_r = t_f = 6 ns)	4.5 9.0	60 100	mV
Crosstalk (between any switches)		Adjust V_{IN} to obtain 0dBm at input $R_L = 600 \ \Omega, \ C_L = 50 \ pF$ $f_{IN} = 1 \ MHz$, sine wave	4.5 9.0	-60 -60	dB

Note: These characteristics are determined by design of devices.

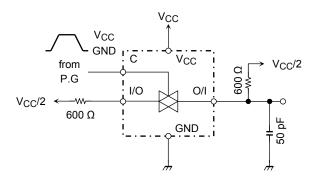
Switching Characteristics Test Circuits

1. t_{pLZ} , t_{pHZ} , t_{pZL} , t_{pZH}

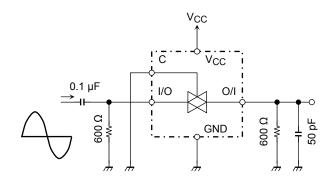




2. Cross Talk (control input-switch output) fIN = 1 MHz duty = 50% tr = tf = 6 ns

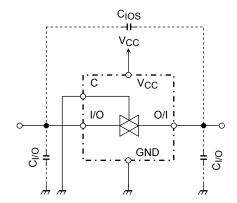


3. Feedthrough Attenuation

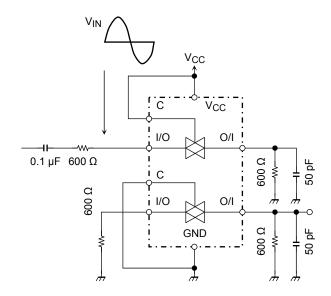




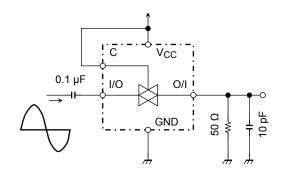
4. C_{IOS}, C_{I/O}



5. Crosstalk (between any two switches)



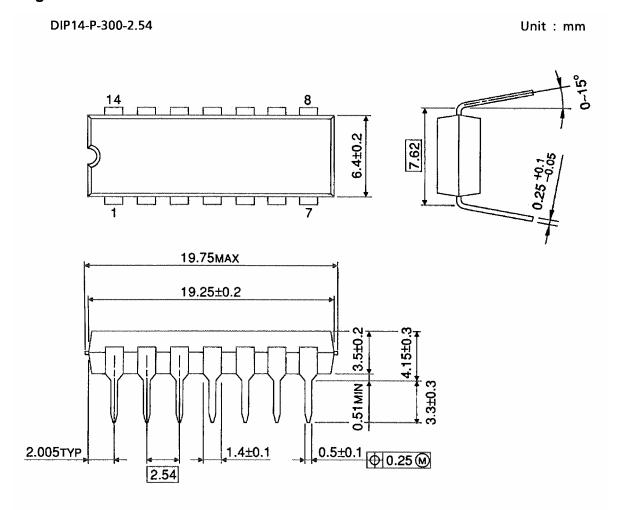
6. Frequency Response (switch on)



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Package Dimensions



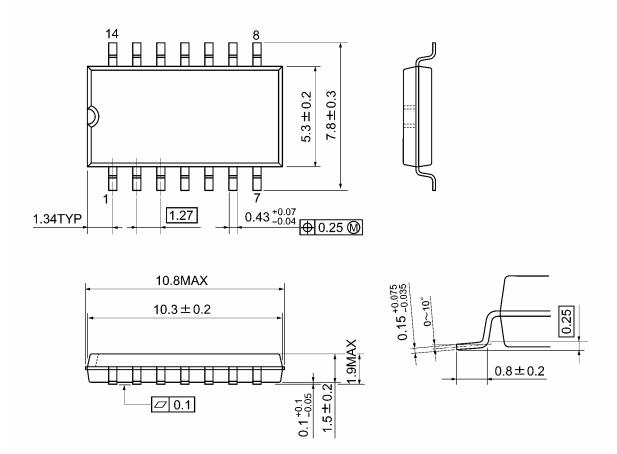
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Weight: 0.96 g (typ.)



Package Dimensions

SOP14-P-300-1.27A Unit: mm

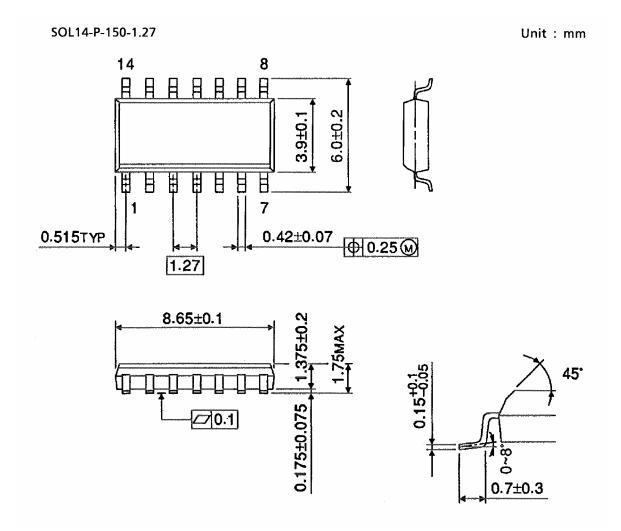


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Weight: 0.18 g (typ.)



Package Dimensions (Note)

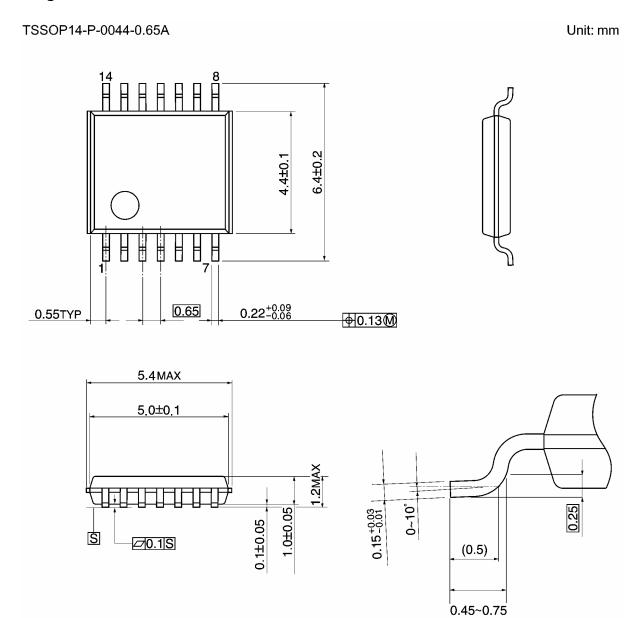


Note: This package is not available in Japan.

Weight: 0.12 g (typ.)



Package Dimensions



Weight: 0.06 g (typ.)

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20070701-EN GENERAL

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